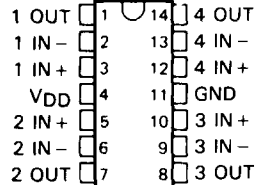


TLC27L4, TLC27L4A, TLC27L4B, TLC27L9 LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

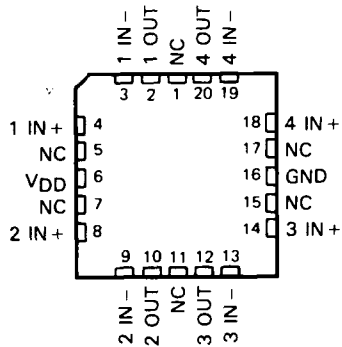
D3142, OCTOBER 1987—REVISED OCTOBER 1990

- **Trimmed Offset Voltage:**
TLC27L9 . . . 900 μ V Max at 25°C,
V_{DD} = 5 V
- **Input Offset Voltage Drift . . . Typically**
0.1 μ V/Month, Including the First 30 Days
- **Wide Range of Supply Voltages Over Specified Temperature Range:**
0°C to 70°C . . . 3 V to 16 V
–40°C to 85°C . . . 4 V to 16 V
–55°C to 125°C . . . 4 V to 16 V
- **Single-Supply Operation**
- **Common-Mode Input Voltage Range**
Extends Below the Negative Rail (C-Suffix,
I-Suffix types)
- **Ultra-Low Power . . . Typically 195 μ W**
at 25°C, V_{DD} = 5 V
- **Output Voltage Range Includes Negative Rail**
- **High Input Impedance . . . 10¹² Ω Typical**
- **ESD-Protection Circuitry**
- **Small-Outline Package Option Also Available**
in Tape and Reel
- **Designed-In Latch-Up Immunity**

**D, J, OR N PACKAGE
(TOP VIEW)**



**FK PACKAGE
(TOP VIEW)**



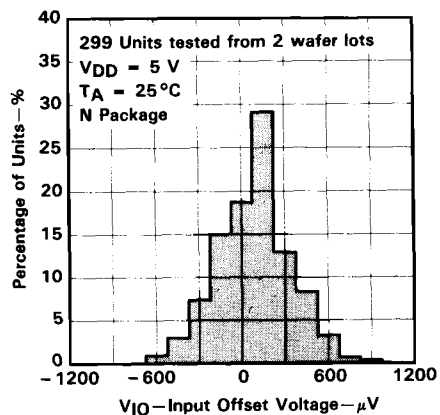
NC—No internal connection

AVAILABLE OPTIONS

T _A	V _{IO} max at 25°C	PACKAGE			
		SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)
0°C to 70°C	900 μ V	TLC27L9CD	—	—	TLC27L9CN
	2 mV	TLC27L4BCD	—	—	TLC27L4BCN
	5 mV	TLC27L4ACD	—	—	TLC27L4ACN
	10 mV	TLC27L4CD	—	—	TLC27L4CN
–40°C to 85°C	900 μ V	TLC27L9ID	—	—	TLC27L9IN
	2 mV	TLC27L4BID	—	—	TLC27L4BIN
	5 mV	TLC27L4AID	—	—	TLC27L4AIN
	10 mV	TLC27L4ID	—	—	TLC27L4IN
–55°C to 125°C	900 μ V	TLC27L9MD	TLC27L9MFK	TLC27L9MJ	TLC27L9MN
	10 mV	TLC27L4MD	TLC27L4MFK	TLC27L4MJ	TLC27L4MN

The D package is available in tape and reel. Add R suffix to the device type, (e.g., TLC27L9CDR).

**DISTRIBUTION OF TLC27L9
INPUT OFFSET VOLTAGE**



LinCMOS is a trademark of Texas Instruments Incorporated

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1990, Texas Instruments Incorporated

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

description

The TLC27L4 and TLC27L9 quad operational amplifiers combine a wide range of input offset voltage grades with low offset voltage drift, high input impedance, extremely low power, and high gain.

These devices use Texas Instruments silicon-gate LinCMOS™ technology, which provides offset voltage stability far exceeding the stability available with conventional metal-gate processes.

The extremely high input impedance, low bias currents, and low power consumption make these cost-effective devices ideal for high gain, low frequency, low power applications. Four offset voltage grades are available (C-suffix and I-suffix types), ranging from the low-cost TLC27L4 (10 mV) to the high-precision TLC27L9 (900 μ V). These advantages, in combination with good common-mode rejection and supply voltage rejection, make these devices a good choice for new state-of-the-art designs as well as for upgrading existing designs.

In general, many features associated with bipolar technology are available on LinCMOS™ operational amplifiers, without the power penalties of bipolar technology. General applications such as transducer interfacing, analog calculations, amplifier blocks, active filters, and signal buffering are easily designed with the TLC27L4 and TLC27L9. The devices also exhibit low voltage single-supply operation and ultra-low power consumption, making them ideally suited for remote and inaccessible battery-powered applications. The common-mode input voltage range includes the negative rail.

A wide range of packaging options is available, including small-outline and chip carrier versions for high-density system applications.

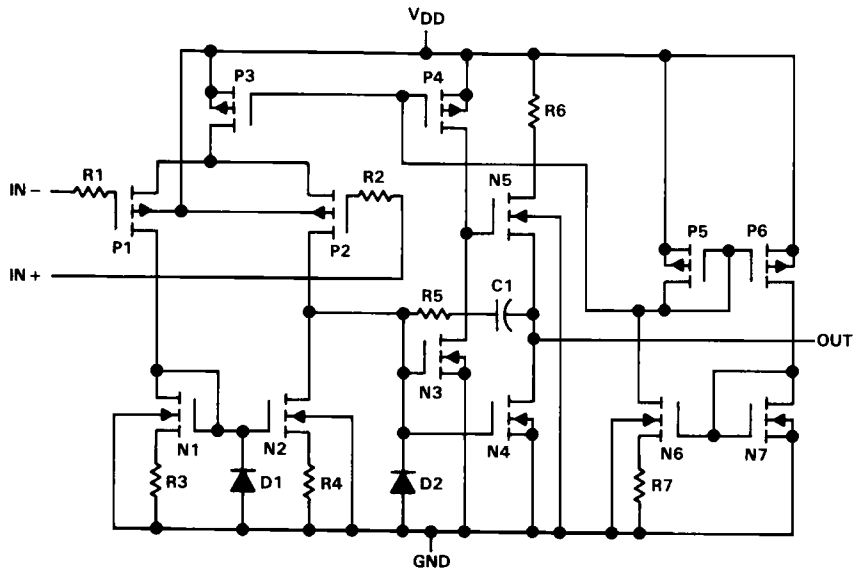
The device inputs and outputs are designed to withstand –100-mA surge currents without sustaining latch-up.

The TLC27L4 and TLC27L9 incorporate internal ESD-protection circuits that prevent functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2; however, care should be exercised in handling these devices, as exposure to ESD may result in the degradation of the device parametric performance.

C-suffix devices are characterized for operation from 0°C to 70°C. I-suffix devices are characterized for operation from –40°C to 85°C. M-suffix devices are characterized for operation from –55°C to 125°C.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

equivalent schematic (each amplifier)



TLC27L4, TLC27L4A, TLC27L4B, TLC27L9

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

absolute maximum ratings over operating free-air temperature (unless otherwise noted)

Supply voltage, V_{DD} (see Note 1)	18 V
Differential input voltage (see Note 2)	$\pm V_{DD}$
Input voltage range, V_I (any input)	$-0.3 \text{ V to } V_{DD}$
Input current, I_I	$\pm 5 \text{ mA}$
Output current, I_O (each output)	$\pm 30 \text{ mA}$
Total current into V_{DD} terminal	45 mA
Total current out of ground terminal	45 mA
Duration of short-circuit current at (or below) 25°C . (see Note 3)	Unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature, T_A : C-suffix	$0^\circ\text{C to } 70^\circ\text{C}$
I-suffix	$-40^\circ\text{C to } 85^\circ\text{C}$
M-suffix	$-55^\circ\text{C to } 125^\circ\text{C}$
Storage temperature range	$-65^\circ\text{C to } 150^\circ\text{C}$
Case temperature for 60 seconds: FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D and N package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J package	300°C

- NOTES: 1. All voltage values, except differential voltages, are with respect to network ground.
2. Differential voltages are at the noninverting input with respect to the inverting input.
3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded (see application section).

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING		POWER RATING	POWER RATING	POWER RATING
D	950 mW	7.6 mW/ $^\circ\text{C}$	608 mW	494 mW	
FK	1375 mW	11 mW/ $^\circ\text{C}$	880 mW	715 mW	275 mW
J	1375 mW	11 mW/ $^\circ\text{C}$	880 mW	715 mW	275 mW
N	1575 mW	12.6 mW/ $^\circ\text{C}$	1008 mW	819 mW	

recommended operating conditions

		C-SUFFIX			I-SUFFIX			M-SUFFIX			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{DD}		3	16	16	4	16	16	4	16	16	V
Common-mode input voltage, V_{IC}	$V_{DD} = 5 \text{ V}$	-0.2		3.5	-0.2		3.5	0		3.5	V
	$V_{DD} = 10 \text{ V}$	-0.2		8.5	-0.2		8.5	0		8.5	
Operating free-air temperature, T_A		0		70	-40		85	-55		125	$^\circ\text{C}$

TLC27L4C, TLC27L4AC, TLC27L4BC, TLC27L9C
linCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A^\dagger	MIN	TYP	MAX	UNIT
V_{IO} Input offset voltage	TLC27L4C	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$, $V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	1.1	10		mV
			Full range		12		
	TLC27L4AC	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$, $V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	0.9	5		
			Full range		6.5		
	TLC27L4BC	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$, $V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	240	2000		μV
			Full range		3000		
	TLC27L9C	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$, $V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	200	900		
			Full range		1500		
α_{VIO} Average temperature coefficient of input offset voltage			25°C to 70°C	1.1			$\mu\text{V}/^\circ\text{C}$
I_{IO} Input offset current (see Note 4)		$V_O = 2.5\text{ V}$, $V_{IC} = 2.5\text{ V}$	25°C	0.1			pA
			70°C	7	300		
I_{IB} Input bias current (see Note 4)		$V_O = 2.5\text{ V}$, $V_{IC} = 2.5\text{ V}$	25°C	0.6			pA
			70°C	40	600		
V_{ICR} Common-mode input voltage range (see Note 5)			25°C	-0.2 to 4	-0.3 to 4.2		V
			Full range	-0.2 to 3.5			V
V_{OH} High-level output voltage		$V_{ID} = 100\text{ mV}$, $R_L = 1\text{ M}\Omega$	25°C	3.2	4.1		V
			0°C	3	4.1		
			70°C	3	4.2		
V_{OL} Low-level output voltage		$V_{ID} = -100\text{ mV}$, $I_{OL} = 0$	25°C	0	50		mV
			0°C	0	50		
			70°C	0	50		
A_{VD} Large-signal differential voltage amplification		$V_O = 0.25\text{ V}$ to 2 V , $R_L = 1\text{ M}\Omega$	25°C	50	520		V/mV
			0°C	50	680		
			70°C	50	380		
CMRR Common-mode rejection ratio		$V_{IC} = V_{ICR\text{ min}}$	25°C	65	94		dB
			0°C	60	95		
			70°C	60	95		
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5\text{ V}$ to 10 V , $V_O = 1.4\text{ V}$	25°C	70	97		dB
			0°C	60	97		
			70°C	60	98		
I_{DD} Supply current (four amplifiers)		$V_O = 2.5\text{ V}$, $V_{IC} = 2.5\text{ V}$, No load	25°C	40	68		μA
			0°C	48	84		
			70°C	31	56		

† Full range is 0°C to 70°C .

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
5. This range also applies to each input individually.

TLC27L4C, TLC27L4AC, TLC27L4BC, TLC27L9C

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 10\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A [†]	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage	TLC27L4C	V _O = 1.4 V,	V _{IC} = 0,	25°C	1.1	10	mV
			R _S = 50 Ω,	R _L = 1 MΩ	Full range		12	
		TLC27L4AC	V _O = 1.4 V,	V _{IC} = 0,	25°C	0.9	5	μV
			R _S = 50 Ω,	R _L = 1 MΩ	Full range		6.5	
	TLC27L4BC	V _O = 1.4 V,	V _{IC} = 0,	25°C	260	2000		
		R _S = 50 Ω,	R _L = 1 MΩ	Full range		3000		
	TLC27L9C	V _O = 1.4 V,	V _{IC} = 0,	25°C	210	1200		
		R _S = 50 Ω,	R _L = 1 MΩ	Full range		1900		
α _{VIO}	Average temperature coefficient of input offset voltage				25°C to 70°C	1		μV/°C
I _{IO}	Input offset current (see Note 4)	V _O = 5 V,	V _{IC} = 5 V	25°C	0.1			pA
				70°C	7	300		
I _{IB}	Input bias current (see Note 4)	V _O = 5 V,	V _{IC} = 5 V	25°C	0.7			pA
				70°C	50	600		
V _{ICR}	Common-mode input voltage range (see Note 5)			25°C	-0.2 to 9	-0.3 to 9.2		V
				Full range	-0.2 to 8.5			V
V _{OH}	High-level output voltage	V _{ID} = 100 mV,	R _L = 1 MΩ	25°C	8	8.9		V
				0°C	7.8	8.9		
				70°C	7.8	8.9		
V _{OL}	Low-level output voltage	V _{ID} = -100 mV,	I _{OL} = 0	25°C	0	50		mV
				0°C	0	50		
				70°C	0	50		
A _{VD}	Large-signal differential voltage amplification	V _O = 1 V to 6 V,	R _L = 1 MΩ	25°C	50	870		V/mV
				0°C	50	1020		
				70°C	50	660		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min		25°C	65	97		dB
				0°C	60	97		
				70°C	60	97		
k _{SVR}	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V,	V _O = 1.4 V	25°C	70	97		dB
				0°C	60	97		
				70°C	60	98		
I _{DD}	Supply current (four amplifiers)	V _O = 5 V,	V _{IC} = 5 V,	25°C		57	92	μA
				0°C		72	132	
				70°C		44	80	

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

TLC27L4I, TLC27L4AI, TLC27L4BI, TLC27L9I
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A^\dagger	MIN	TYP	MAX	UNIT
V_{IO} Input offset voltage	TLC27L4I	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C		1.1	10	mV
				Full range			13	
	TLC27L4AI	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C		0.9	5	
				Full range			7	
	TLC27L4BI	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C		240	2000	μV
				Full range			3500	
	TLC27L9I	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C		200	900	
				Full range			2000	
α_{VIO} Average temperature coefficient of input offset voltage				25°C to 85°C		1.1		$\mu\text{V}/^\circ\text{C}$
I_{IO} Input offset current (see Note 4)		$V_O = 2.5\text{ V}$, $V_{IC} = 2.5\text{ V}$		25°C		0.1		pA
				85°C		24	1000	
I_{IB} Input bias current (see Note 4)		$V_O = 2.5\text{ V}$, $V_{IC} = 2.5\text{ V}$		25°C		0.6		pA
				85°C		200	2000	
V_{ICR} Common-mode input voltage range (see Note 5)				25°C	-0.2 to 4	-0.3 to 4.2		V
				Full range	-0.2 to 3.5			V
V_{OH} High-level output voltage		$V_{ID} = 100\text{ mV}$, $R_L = 1\text{ M}\Omega$		25°C		3.2	4.1	V
				-40°C		3	4.1	
				85°C		3	4.2	
V_{OL} Low-level output voltage		$V_{ID} = -100\text{ mV}$, $I_{OL} = 0$		25°C		0	50	mV
				-40°C		0	50	
				85°C		0	50	
A_{VD} Large-signal differential voltage amplification		$V_O = 0.25\text{ V to } 2\text{ V}$, $R_L = 1\text{ M}\Omega$		25°C		50	480	V/mV
				-40°C		50	900	
				85°C		50	330	
CMRR Common-mode rejection ratio		$V_{IC} = V_{ICR\text{ min}}$		25°C		65	94	dB
				-40°C		60	95	
				85°C		60	95	
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5\text{ V to } 10\text{ V}$, $V_O = 1.4\text{ V}$		25°C		70	97	dB
				-40°C		60	97	
				85°C		60	98	
I_{DD} Supply current (four amplifiers)		$V_O = 2.5\text{ V}$, No load	$V_{IC} = 2.5\text{ V}$	25°C		39	68	μA
				-40°C		62	108	
				85°C		29	52	

† Full range is -40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

TLC27L4I, TLC27L4AI, TLC27L4BI, TLC27L9I

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 10$ V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A^\dagger	MIN	TYP	MAX	UNIT
V_{IO} Input offset voltage	TLC27L4I	$V_O = 1.4$ V, $R_S = 50\ \Omega$,	$V_{IC} = 0$, $R_L = 1\ M\Omega$	25°C	1.1	10		mV
				Full range		13		
	TLC27L4AI	$V_O = 1.4$ V, $R_S = 50\ \Omega$,	$V_{IC} = 0$, $R_L = 1\ M\Omega$	25°C	0.9	5		
				Full range		7		
	TLC27L4BI	$V_O = 1.4$ V, $R_S = 50\ \Omega$,	$V_{IC} = 0$, $R_L = 1\ M\Omega$	25°C	260	2000		μ V
				Full range		3500		
	TLC27L9I	$V_O = 1.4$ V, $R_S = 50\ \Omega$,	$V_{IC} = 0$, $R_L = 1\ M\Omega$	25°C	210	1200		
				Full range		2900		
α_{VIO} Average temperature coefficient of input offset voltage				25°C to 85°C	1			μ V/°C
I_{IO} Input offset current (see Note 4)		$V_O = 5$ V,	$V_{IC} = 5$ V	25°C	0.1			pA
				85°C	26	1000		
I_{IB} Input bias current (see Note 4)		$V_O = 5$ V,	$V_{IC} = 5$ V	25°C	0.7			pA
				85°C	220	2000		
V_{ICR} Common-mode input voltage range (see Note 5)				25°C	-0.2 to 9	-0.3 to 9.2		V
				Full range	-0.2 to 8.5			V
V_{OH} High-level output voltage		$V_{ID} = 100$ mV,	$R_L = 1\ M\Omega$	25°C	8	8.9		V
				-40°C	7.8	8.9		
				85°C	7.8	8.9		
V_{OL} Low-level output voltage		$V_{ID} = -100$ mV,	$I_{OL} = 0$	25°C	0	50		mV
				-40°C	0	50		
				85°C	0	50		
A_{VD} Large-signal differential voltage amplification		$V_O = 1$ V to 6 V,	$R_L = 1\ M\Omega$	25°C	50	800		V/mV
				-40°C	50	1550		
				85°C	50	585		
CMRR Common-mode rejection ratio		$V_{IC} = V_{ICR\ min}$		25°C	65	97		dB
				-40°C	60	97		
				85°C	60	98		
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5$ V to 10 V, $V_O = 1.4$ V		25°C	70	97		dB
				-40°C	60	97		
				85°C	60	98		
I_{DD} Supply current (four amplifiers)		$V_O = 5$ V, No load	$V_{IC} = 5$ V,	25°C		57	92	μ A
				-40°C		98	172	
				85°C		40	72	

† Full range is -40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

TLC27L4M, TLC27L9M
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 5\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T _A [†]	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage	TLC27L4M	V _O = 1.4 V,	V _{IC} = 0,	25°C	1.1	10	mV
			R _S = 50 Ω,	R _L = 1 MΩ	Full range		12	
		TLC27L9M	V _O = 1.4 V,	V _{IC} = 0,	25°C	200	900	μV
			R _S = 50 Ω,	R _L = 1 MΩ	Full range		3750	
αV _{IO}	Average temperature coefficient of input offset voltage			25°C to 125°C	1.4			μV/°C
I _{IO}	Input offset current (see Note 4)	V _O = 2.5 V,	V _{IC} = 2.5 V	25°C	0.1			pA
				125°C	1.4	15		nA
I _{IB}	Input bias current (see Note 4)	V _O = 2.5 V,	V _{IC} = 2.5 V	25°C	0.6			pA
				125°C	9	35		nA
V _{ICR}	Common-mode input voltage range (see Note 5)			25°C	0 to 4	−0.3 to 4.2		V
				Full range	0 to 3.5			V
V _{OH}	High-level output voltage	V _{ID} = 100 mV,	R _L = 1 MΩ	25°C	3.2	4.1		V
				−55°C	3	4.1		
				125°C	3	4.2		
V _{OL}	Low-level output voltage	V _{ID} = −100 mV,	I _{OL} = 0	25°C		0	50	mV
				−55°C		0	50	
				125°C		0	50	
A _{VD}	Large-signal differential voltage amplification	V _O = 0.25 V to 2 V, R _L = 1 MΩ		25°C	50	480		V/mV
				−55°C	25	950		
				125°C	25	200		
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min		25°C	65	94		dB
				−55°C	60	95		
				125°C	60	85		
k _{SVR}	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V, V _O = 1.4 V		25°C	70	97		dB
				−55°C	60	97		
				125°C	60	98		
I _{DD}	Supply current (four amplifiers)	V _O = 2.5 V, No load	V _{IC} = 2.5 V,	25°C		39	68	μA
				−55°C		69	120	
				125°C		27	48	

† Full range is -55°C to 125°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

TLC27L4M, TLC27L9M

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

electrical characteristics at specified free-air temperature, $V_{DD} = 10\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A^\dagger	MIN	TYP	MAX	UNIT
V_{IO} Input offset voltage	TLC27L4M	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	1.1	10		mV
				Full range		12		
	TLC27L9M	$V_O = 1.4\text{ V}$, $R_S = 50\ \Omega$	$V_{IC} = 0$, $R_L = 1\text{ M}\Omega$	25°C	210	1200		μV
				Full range		4300		
α_{VIO} Average temperature coefficient of input offset voltage				25°C to 125°C	1.4			$\mu\text{V}/^\circ\text{C}$
I_{IO} Input offset current (see Note 4)		$V_O = 5\text{ V}$	$V_{IC} = 5\text{ V}$	25°C	0.1			pA
				125°C	1.8	15		nA
I_{IB} Input bias current (see Note 4)		$V_O = 5\text{ V}$	$V_{IC} = 5\text{ V}$	25°C	0.7			pA
				125°C	10	35		nA
V_{ICR} Common-mode input voltage range (see Note 5)				25°C	0 to 9	-0.3 to 9.2		V
				Full range	0 to 8.5			V
V_{OH} High-level output voltage		$V_{ID} = 100\text{ mV}$	$R_L = 1\text{ M}\Omega$	25°C	8	8.9		V
				-55°C	7.8	8.8		
				125°C	7.8	9		
V_{OL} Low-level output voltage		$V_{ID} = -100\text{ mV}$	$I_{OL} = 0$	25°C	0	50		mV
				-55°C	0	50		
				125°C	0	50		
A_{VD} Large-signal differential voltage amplification		$V_O = 1\text{ V to }6\text{ V}$	$R_L = 1\text{ M}\Omega$	25°C	50	800		V/mV
				-55°C	25	1750		
				125°C	25	380		
CMRR Common-mode rejection ratio		$V_{IC} = V_{ICR\text{ min}}$		25°C	65	97		dB
				-55°C	60	97		
				125°C	60	91		
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		$V_{DD} = 5\text{ V to }10\text{ V}$	$V_O = 1.4\text{ V}$	25°C	70	97		dB
				-55°C	60	97		
				125°C	60	98		
I_{DD} Supply current (four amplifiers)		$V_O = 5\text{ V}$, No load	$V_{IC} = 5\text{ V}$	25°C	57	92		μA
				-55°C	111	192		
				125°C	35	60		

† Full range is -55°C to 125°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.



TLC27L4C, TLC27L4AC, TLC27L4BC, TLC27L9C
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{IPP} = 1\text{ V}$	25 °C		0.03		$\text{V}/\mu\text{s}$
			0 °C		0.04		
			70 °C		0.03		
		$V_{IPP} = 2.5\text{ V}$	25 °C		0.03		
			0 °C		0.03		
			70 °C		0.02		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$,	25 °C		70		$\text{nV}/\sqrt{\text{Hz}}$
BOM Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25 °C		5		kHz
			0 °C		6		
			70 °C		4.5		
B ₁ Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$,	25 °C		85		kHz
			0 °C		100		
			70 °C		65		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$,	$f = B_1$, See Figure 3	25 °C		34 °		
			0 °C		36 °		
			70 °C		30 °		

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{IPP} = 1\text{ V}$	25 °C		0.05		$\text{V}/\mu\text{s}$
			0 °C		0.05		
			70 °C		0.04		
		$V_{IPP} = 5.5\text{ V}$	25 °C		0.04		
			0 °C		0.05		
			70 °C		0.04		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$,	25 °C		70		$\text{nV}/\sqrt{\text{Hz}}$
BOM Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25 °C		1		kHz
			0 °C		1.3		
			70 °C		0.9		
B ₁ Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$,	25 °C		110		kHz
			0 °C		125		
			70 °C		90		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$,	$f = B_1$, See Figure 3	25 °C		38 °		
			0 °C		40 °		
			70 °C		34 °		

TLC27L4I, TLC27L4AI, TLC27L4BI, TLC27L9I

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{Ipp} = 1\text{ V}$	25 °C		0.03		$\text{V}/\mu\text{s}$
			-40 °C		0.04		
			85 °C		0.03		
		$V_{Ipp} = 2.5\text{ V}$	25 °C		0.03		
			-40 °C		0.04		
			85 °C		0.02		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$	25 °C		70		$\text{nV}/\sqrt{\text{Hz}}$
B_{OM} Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25 °C		5		kHz
			-40 °C		7		
			85 °C		4		
B_1 Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$	25 °C		85		kHz
			-40 °C		130		
			85 °C		55		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$	$f = B_1$, See Figure 3	25 °C		34 °		
			-40 °C		38 °		
			85 °C		28 °		

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{Ipp} = 1\text{ V}$	25 °C		0.05		$\text{V}/\mu\text{s}$
			-40 °C		0.06		
			85 °C		0.03		
		$V_{Ipp} = 5.5\text{ V}$	25 °C		0.04		
			-40 °C		0.05		
			85 °C		0.03		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$	25 °C		70		$\text{nV}/\sqrt{\text{Hz}}$
B_{OM} Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25 °C		1		kHz
			-40 °C		1.4		
			85 °C		0.8		
B_1 Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$	25 °C		110		kHz
			-40 °C		155		
			85 °C		80		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$	$f = B_1$, See Figure 3	25 °C		38 °		
			-40 °C		42 °		
			85 °C		32 °		

TLC27L4M, TLC27L9M
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{Ipp} = 1\text{ V}$	25°C		0.03		$\text{V}/\mu\text{s}$
			-55°C		0.04		
			125°C		0.02		
		$V_{Ipp} = 2.5\text{ V}$	25°C		0.03		
			-55°C		0.04		
			125°C		0.02		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$,	25°C		70		$\text{nV}/\sqrt{\text{Hz}}$
B_{OM} Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25°C		5		kHz
			-55°C		8		
			125°C		3		
B_1 Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$,	25°C		85		kHz
			-55°C		140		
			125°C		45		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$,	$f = B_1$, See Figure 3	25°C		34°		
			-55°C		39°		
			125°C		25°		

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS		T_A	MIN	TYP	MAX	UNIT
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$, See Figure 1	$V_{Ipp} = 1\text{ V}$	25°C		0.05		$\text{V}/\mu\text{s}$
			-55°C		0.06		
			125°C		0.03		
		$V_{Ipp} = 5.5\text{ V}$	25°C		0.04		
			-55°C		0.06		
			125°C		0.03		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, See Figure 2	$R_S = 100\ \Omega$,	25°C		70		$\text{nV}/\sqrt{\text{Hz}}$
B_{OM} Maximum output swing bandwidth	$V_O = V_{OH}$, $R_L = 1\text{ M}\Omega$, See Figure 1	$C_L = 20\text{ pF}$, See Figure 1	25°C		1		kHz
			-55°C		1.5		
			125°C		0.7		
B_1 Unity-gain bandwidth	$V_i = 10\text{ mV}$, See Figure 3	$C_L = 20\text{ pF}$,	25°C		110		kHz
			-55°C		165		
			125°C		70		
ϕ_m Phase margin	$V_i = 10\text{ mV}$, $C_L = 20\text{ pF}$,	$f = B_1$, See Figure 3	25°C		38°		
			-55°C		43°		
			125°C		29°		

PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

Because the TLC27L4 and TLC27L9 are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit will give the same result.



FIGURE 1. UNITY-GAIN AMPLIFIER

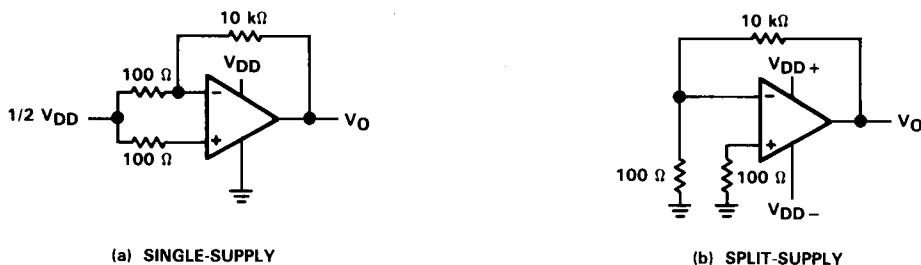


FIGURE 2. NOISE TEST CIRCUIT

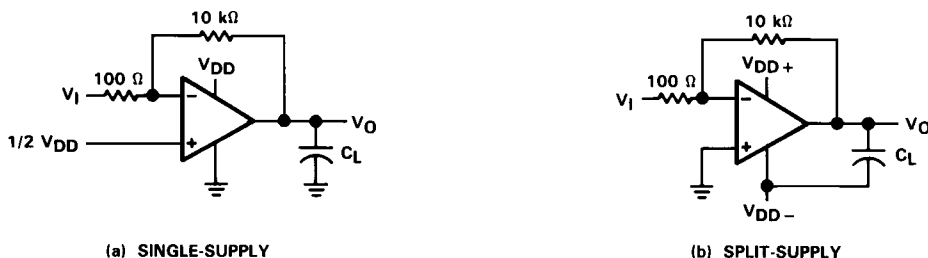


FIGURE 3. GAIN-OF-100 INVERTING AMPLIFIER

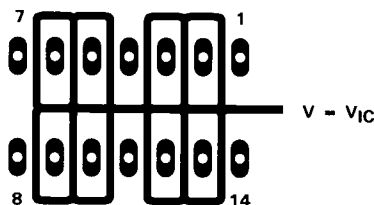
PARAMETER MEASUREMENT INFORMATION

input bias current

Because of the high input impedance of the TLC27L4 and TLC27L9 op amps, attempts to measure the input bias current can result in erroneous readings. The bias current at normal room ambient temperature is typically less than 1 pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

1. Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 4). Leakages that would otherwise flow to the inputs will be shunted away.
2. Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the "open-socket" leakage readings from the readings obtained with a device in the test socket.

One word of caution . . . many automatic testers as well as some bench-top op amp testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into the test socket to obtain a correct reading; therefore, an "open-socket" reading is not feasible using this method.



**FIGURE 4. ISOLATION METAL AROUND DEVICE INPUTS
(J AND N DUAL-IN-LINE-PACKAGE)**

low-level output voltage

To obtain low-supply-voltage operation, some compromise was necessary in the input stage. This compromise results in the device low-level output being dependent on both the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions should be observed. If conditions other than these are to be used, please refer to Figures 14 through 19 in the Typical Characteristics of this data sheet.

input offset voltage temperature coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture will result in leakage and contact resistance, which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal itself, thereby rendering it useless. It is suggested that these measurements be performed at temperatures above freezing to minimize error.

PARAMETER MEASUREMENT INFORMATION

full-power response

Full-power response, the frequency above which the op amp slew rate limits the output voltage swing, is often specified two ways . . . full-linear response and full-peak response. The full-linear response is generally measured by monitoring the distortion level of the output while increasing the frequency of a sinusoidal input signal until the maximum frequency is found above which the output contains significant distortion. The full-peak response is defined as the maximum output frequency, without regard to distortion, above which full peak-to-peak output swing cannot be maintained.

Because there is no industry-wide accepted value for "significant" distortion, the full-peak response is specified in this data sheet and is measured using the circuit of Figure 1. The initial setup involves the use of a sinusoidal input to determine the maximum peak-to-peak output of the device (the amplitude of the sinusoidal wave is increased until clipping occurs). The sinusoidal wave is then replaced with a square wave of the same amplitude. The frequency is then increased until the maximum peak-to-peak output can no longer be maintained (Figure 5). A square wave is used to allow a more accurate determination of the point at which the maximum peak-to-peak output is reached.

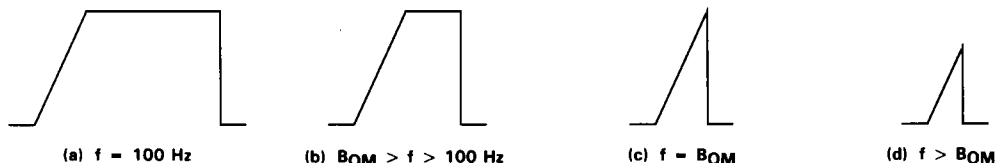


FIGURE 5. FULL-POWER-RESPONSE OUTPUT SIGNAL

test time

Inadequate test time is a frequent problem, especially when testing CMOS devices in a high-volume, short-test-time environment. Internal capacitances are inherently higher in CMOS than in bipolar and BiFET devices and require longer test times than their bipolar and BiFET counterparts. The problem becomes more pronounced with reduced supply levels and lower temperatures.

TYPICAL CHARACTERISTICS

**DISTRIBUTION OF TLC27L4
INPUT OFFSET VOLTAGE**

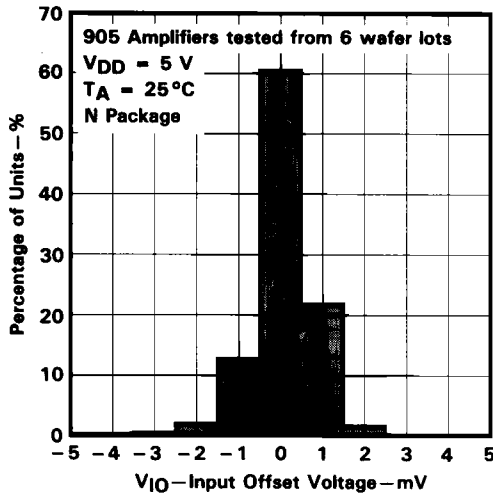


FIGURE 6

**DISTRIBUTION OF TLC27L4
INPUT OFFSET VOLTAGE**

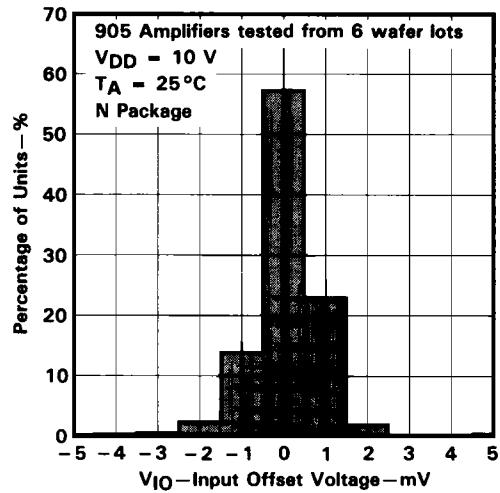


FIGURE 7

**DISTRIBUTION OF TLC27L4 AND TLC27L9
INPUT OFFSET VOLTAGE
TEMPERATURE COEFFICIENT**

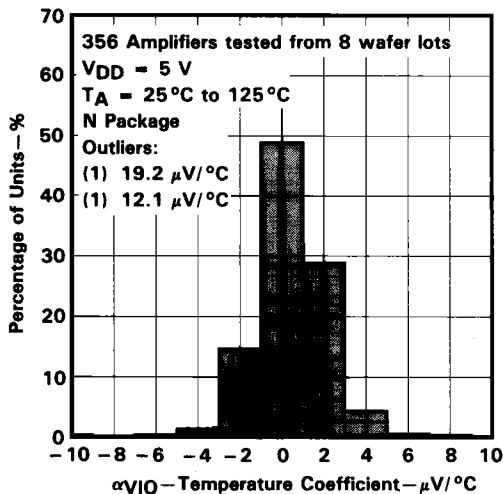


FIGURE 8

**DISTRIBUTION OF TLC27L4 AND TLC27L9
INPUT OFFSET VOLTAGE
TEMPERATURE COEFFICIENT**

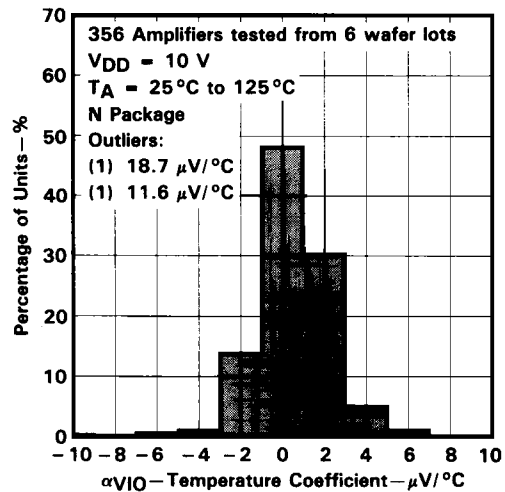


FIGURE 9

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

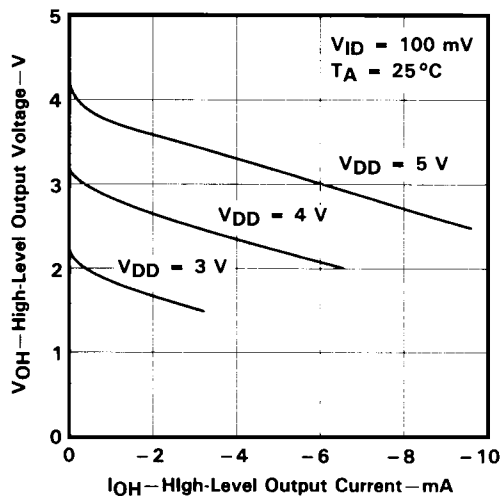


FIGURE 10

HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

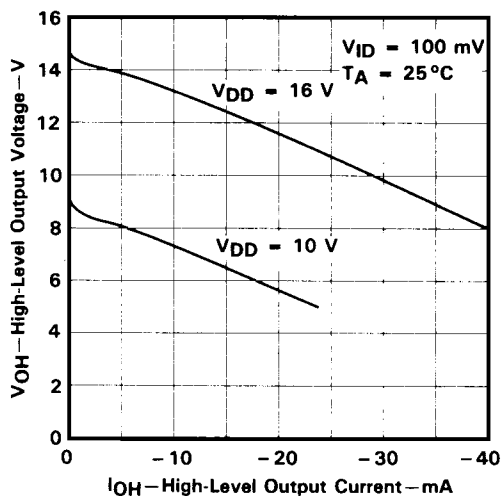


FIGURE 11

HIGH-LEVEL OUTPUT VOLTAGE
vs
SUPPLY VOLTAGE

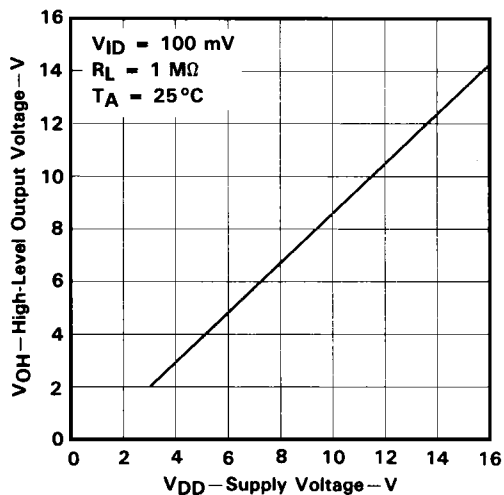


FIGURE 12

HIGH-LEVEL OUTPUT VOLTAGE
vs
FREE-AIR TEMPERATURE

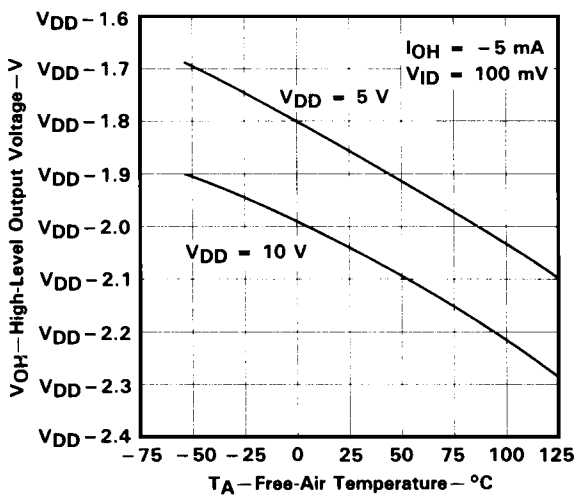


FIGURE 13

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†

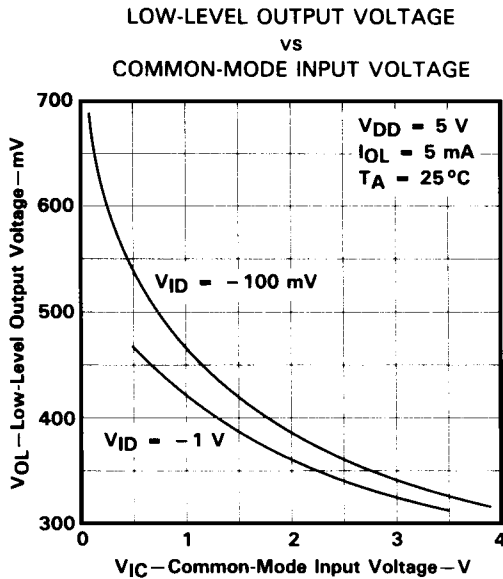


FIGURE 14

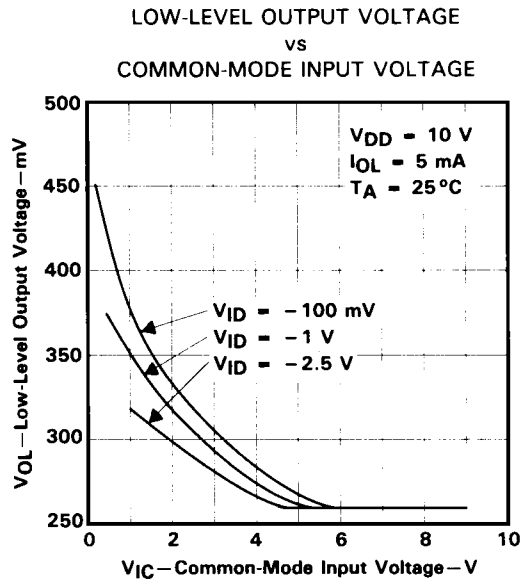


FIGURE 15

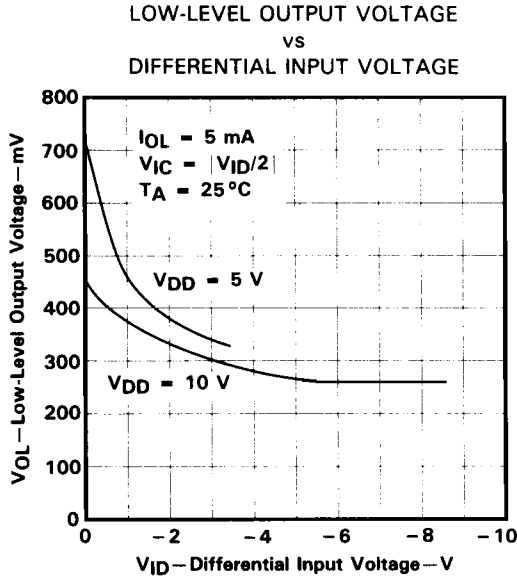


FIGURE 16

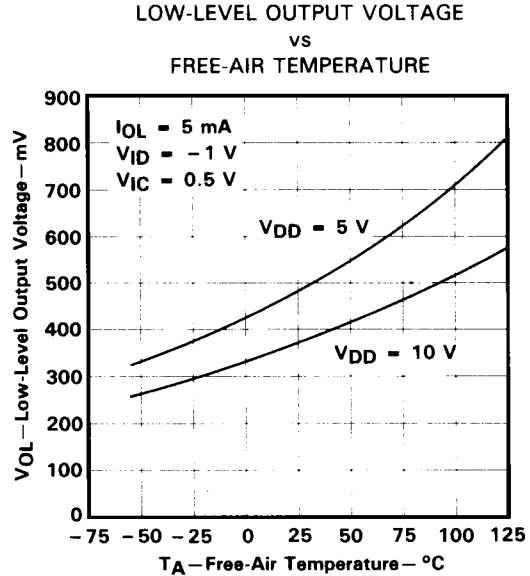


FIGURE 17

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9
linCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

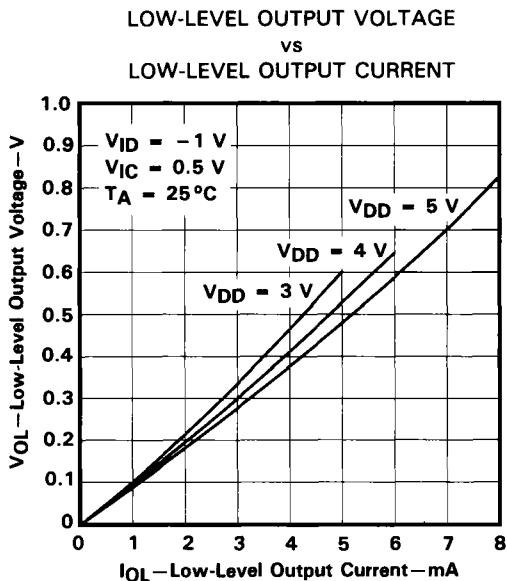


FIGURE 18

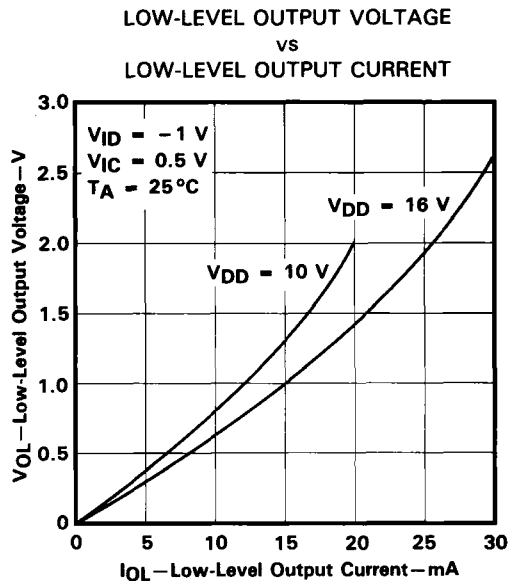


FIGURE 19

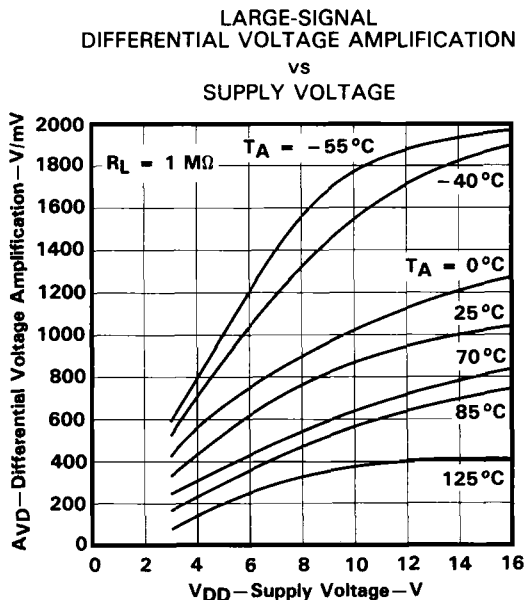


FIGURE 20

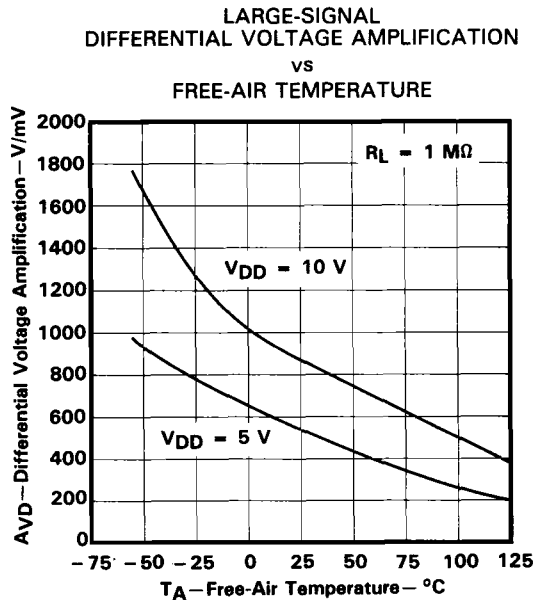


FIGURE 21

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT
vs
FREE-AIR TEMPERATURE

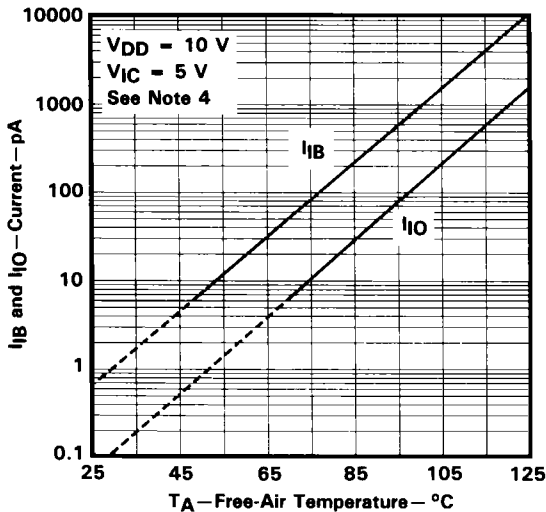


FIGURE 22

COMMON-MODE
INPUT VOLTAGE POSITIVE LIMIT
vs
SUPPLY VOLTAGE

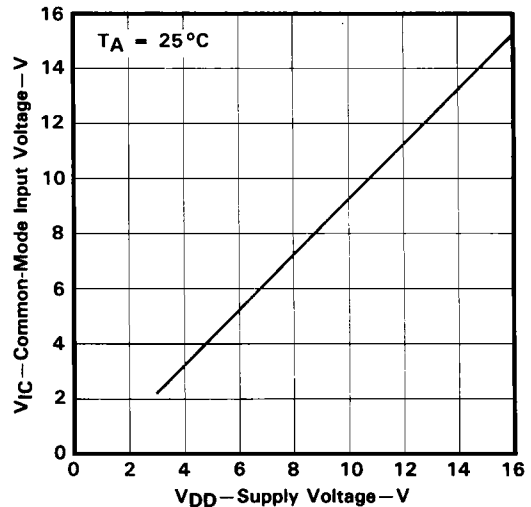


FIGURE 23

SUPPLY CURRENT
vs
SUPPLY VOLTAGE

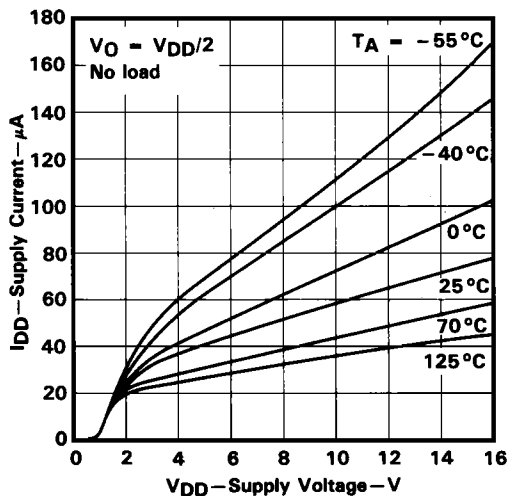


FIGURE 24

SUPPLY CURRENT
vs
FREE-AIR TEMPERATURE

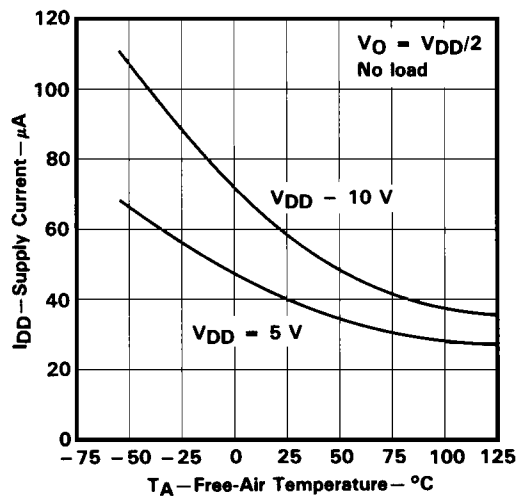


FIGURE 25

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.
NOTE 4: The typical values of input bias current and input offset current below 5 pA were determined mathematically.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9
LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

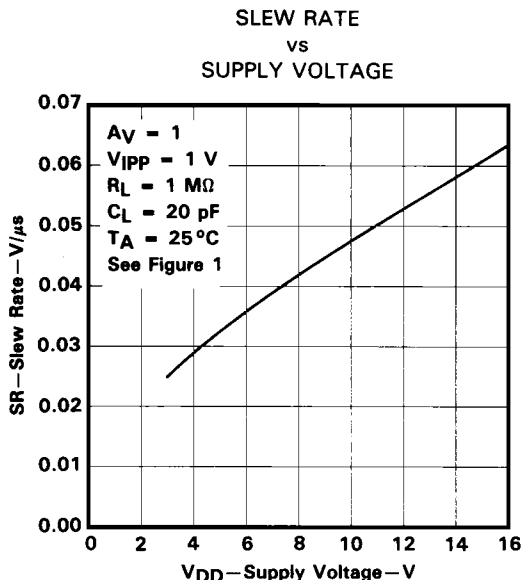


FIGURE 26

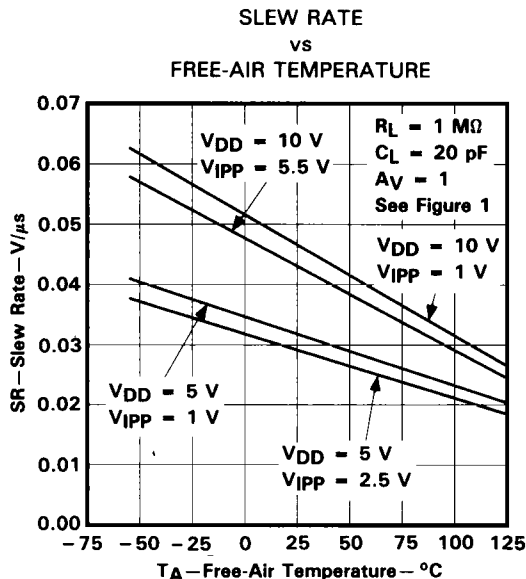


FIGURE 27

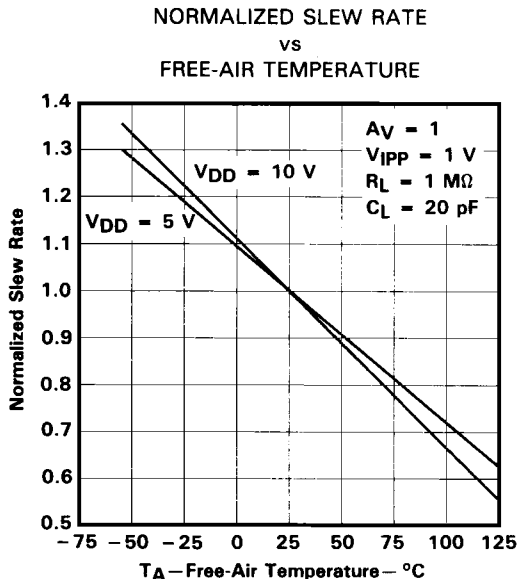


FIGURE 28

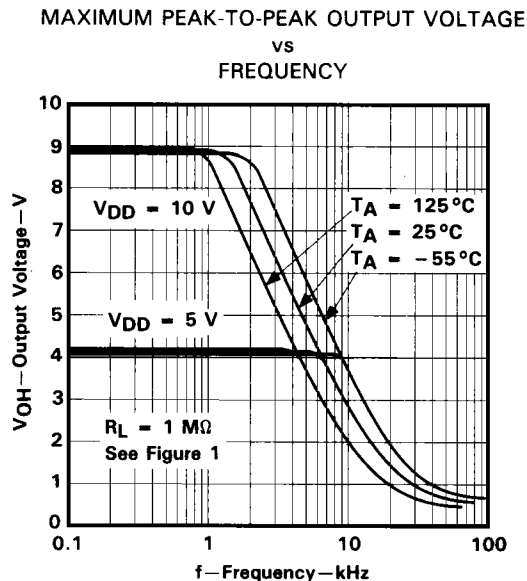


FIGURE 29

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9

LinCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

UNITY-GAIN BANDWIDTH
vs
FREE-AIR TEMPERATURE

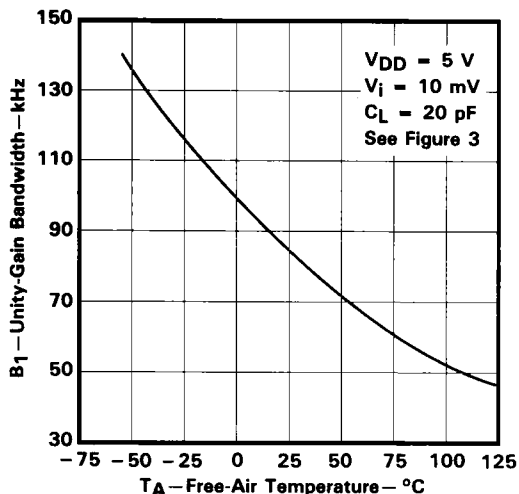


FIGURE 30

UNITY-GAIN BANDWIDTH
vs
SUPPLY VOLTAGE

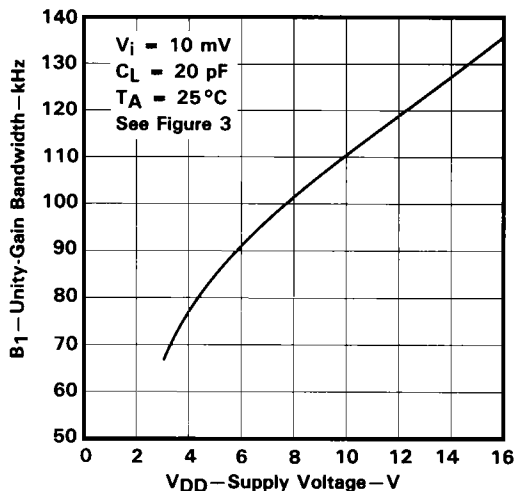


FIGURE 31

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION AND PHASE SHIFT
vs
FREQUENCY

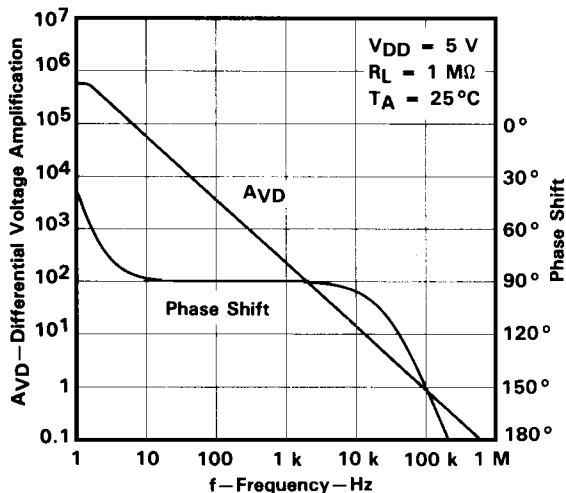


FIGURE 32

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION AND PHASE SHIFT
vs
FREQUENCY

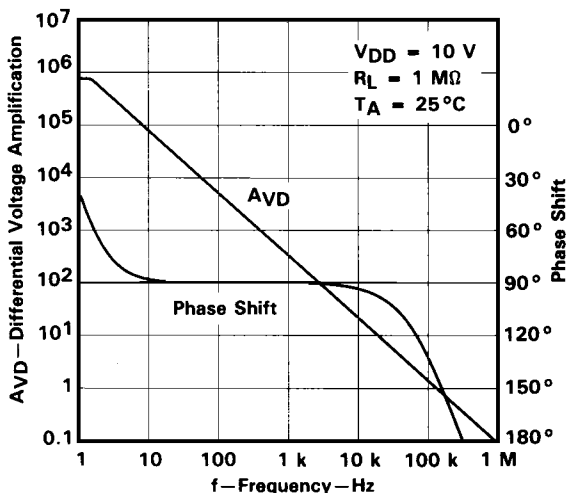


FIGURE 33

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TLC27L4, TLC27L4A, TLC27L4B, TLC27L9
linCMOS™ PRECISION QUAD OPERATIONAL AMPLIFIERS

TYPICAL CHARACTERISTICS†

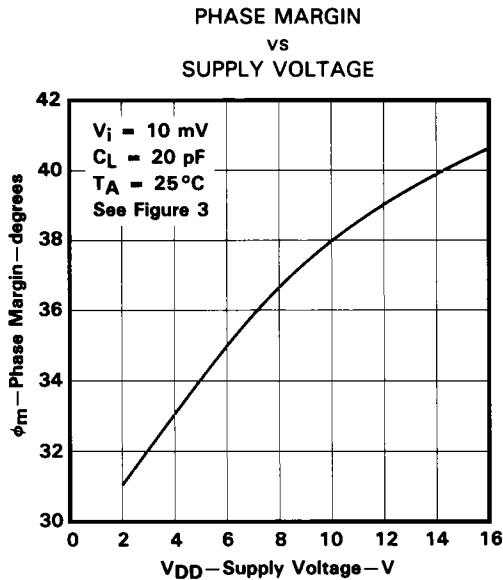


FIGURE 34

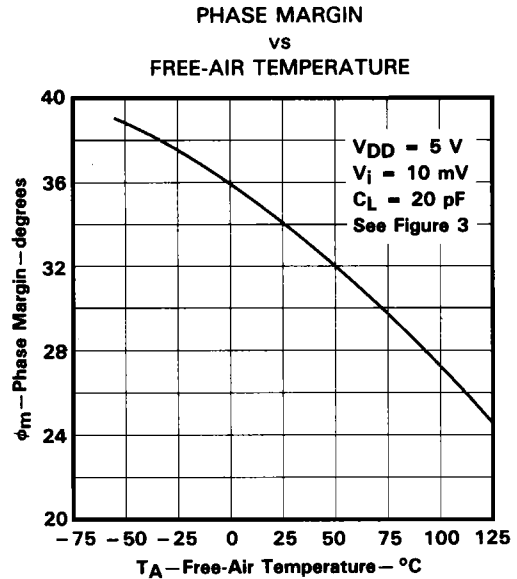


FIGURE 35

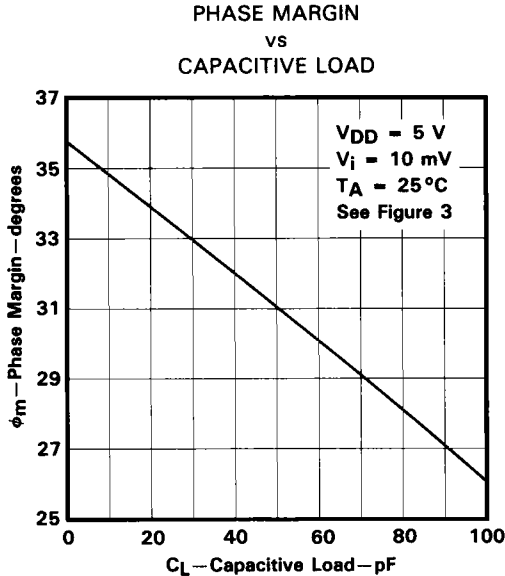


FIGURE 36

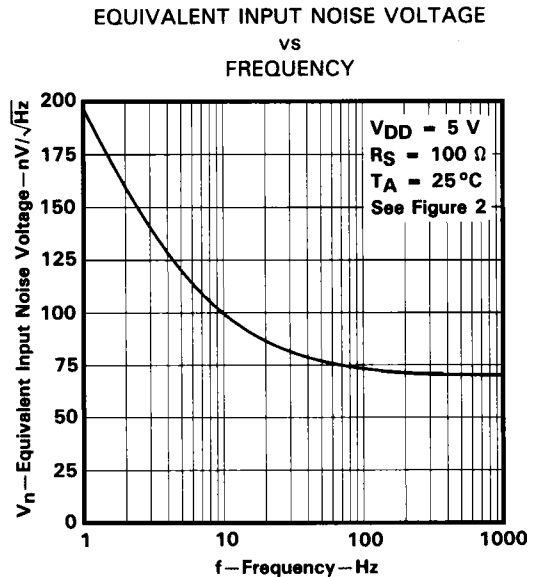


FIGURE 37

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

single-supply operation

While the TLC27L4 and TLC27L9 perform well using dual power supplies (also called balanced or split supplies), the design is optimized for single-supply operation. This design includes an input common-mode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 3 V (C-suffix types), thus allowing operation with supply levels commonly available for TTL and HCMOS; however, for maximum dynamic range, 16-V single-supply operation is recommended.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. A resistive voltage divider is usually sufficient to establish this reference level (see Figure 38). The low input bias current of the TLC27L4 and TLC27L9 permits the use of very large resistive values to implement the voltage divider, thus minimizing power consumption.

The TLC27L4 and TLC27L9 work well in conjunction with digital logic; however, when powering both linear devices and digital logic from the same power supply, the following precautions are recommended:

1. Power the linear devices from separate bypassed supply lines (see Figure 39); otherwise the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic.
2. Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, high-frequency applications may require RC decoupling.

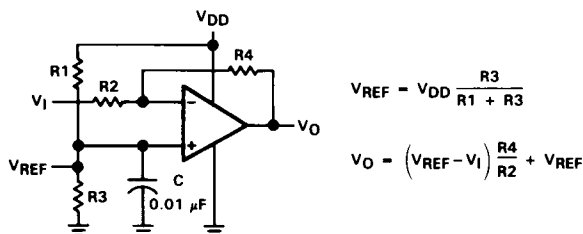


FIGURE 38. INVERTING AMPLIFIER WITH VOLTAGE REFERENCE

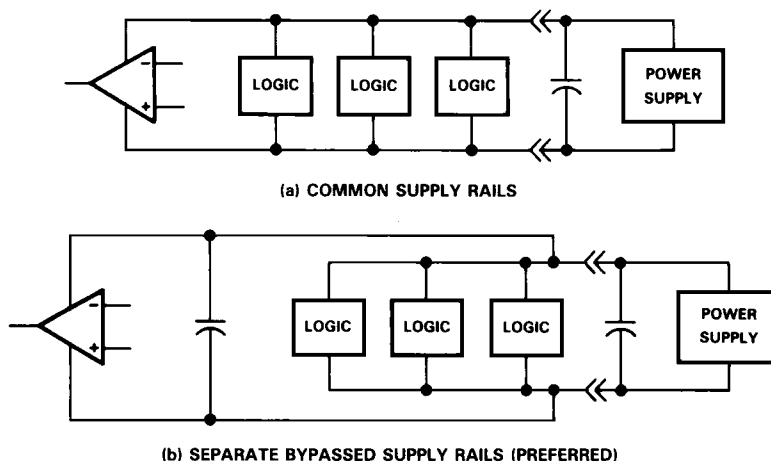


FIGURE 39. COMMON VS SEPARATE SUPPLY RAILS

TYPICAL APPLICATION DATA

input characteristics

The TLC27L4 and TLC27L9 are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. Note that the lower range limit includes the negative rail, while the upper range limit is specified at $V_{DD} - 1$ V at $T_A = 25^\circ\text{C}$ and at $V_{DD} - 1.5$ V at all other temperatures.

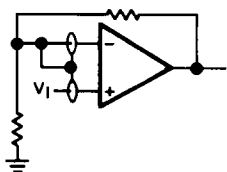
The use of the polysilicon-gate process and the careful input circuit design gives the TLC27L4 and TLC27L9 very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically $0.1\ \mu\text{V}/\text{month}$, including the first month of operation.

Because of the extremely high input impedance and resulting low bias current requirements, the TLC27L4 and TLC27L9 are well suited for low-level signal processing; however, leakage currents on printed circuit boards and sockets can easily exceed bias current requirements and cause a degradation in device performance. It is good practice to include guard rings around inputs (similar to those of Figure 4 in the Parameter Measurement Information section). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 40).

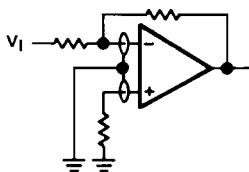
The inputs of any unused amplifiers should be tied to ground to avoid possible oscillation.

noise performance

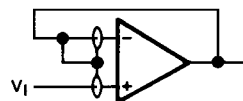
The noise specifications in op amp circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirements of the TLC27L4 and TLC27L9 result in a very low noise current, which is insignificant in most applications. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than $50\ \text{k}\Omega$, since bipolar devices exhibit greater noise currents.



(a) NONINVERTING AMPLIFIER



(b) INVERTING AMPLIFIER



(c) UNITY-GAIN AMPLIFIER

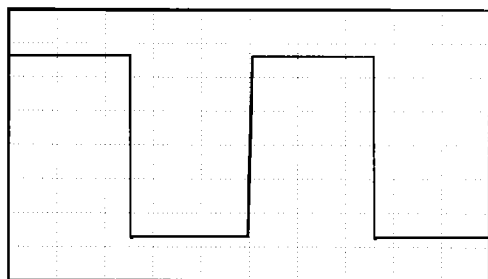
FIGURE 40. GUARD-RING SCHEMES

output characteristics

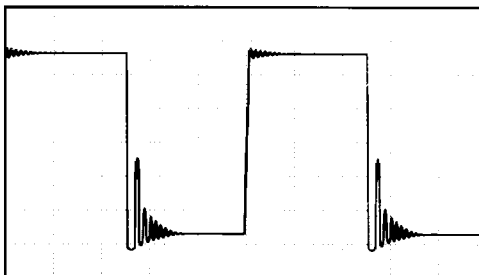
The output stage of the TLC27L4 and TLC27L9 is designed to sink and source relatively high amounts of current (see typical characteristics). If the output is subjected to a short-circuit condition, this high current capability can cause device damage under certain conditions. Output current capability increases with supply voltage.

All operating characteristics of the TLC27L4 and TLC27L9 were measured using a 20-pF load. The devices will drive higher capacitive loads; however, as output load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation (see Figure 41). In many cases, adding a small amount of resistance in series with the load capacitance will alleviate the problem.

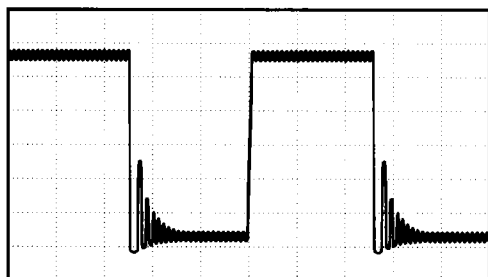
TYPICAL APPLICATION DATA



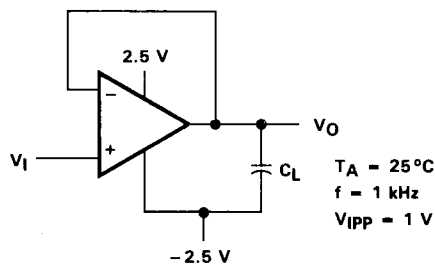
(a) $C_L = 20 \text{ pF}$, $R_L = \text{NO LOAD}$



(b) $C_L = 260 \text{ pF}$, $R_L = \text{NO LOAD}$



(c) $C_L = 310 \text{ pF}$, $R_L = \text{NO LOAD}$



(d) TEST CIRCUIT

FIGURE 41. EFFECT OF CAPACITIVE LOADS AND TEST CIRCUIT

Although the TLC27L4 and TLC27L9 possess excellent high-level output voltage and current capability, methods for boosting this capability are available, if needed. The simplest method involves the use of a pullup resistor (R_p) connected from the output to the positive supply rail (see Figure 42). There are two disadvantages to the use of this circuit. First, the NMOS pulldown transistor N4 (see equivalent schematic) must sink a comparatively large amount of current. In this circuit, N4 behaves like a linear resistor with an on-resistance between approximately 60Ω and 180Ω , depending on how hard the op amp input is driven. With very low values of R_p , a voltage offset from 0 V at the output will occur. Second, pullup resistor R_p acts as a drain load to N4 and the gain of the op amp is reduced at output voltage levels where N5 is not supplying the output current.

feedback

Op amp circuits nearly always employ feedback, and since feedback is the first prerequisite for oscillation, some caution is appropriate. Most oscillation problems result from driving capacitive loads (discussed previously) and ignoring stray input capacitance. A small-value capacitor connected in parallel with the feedback resistor is an effective remedy (see Figure 43). The value of this capacitor is optimized empirically.

TYPICAL APPLICATION DATA

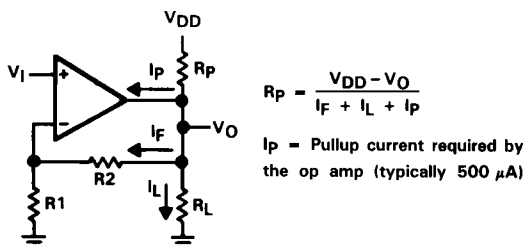


FIGURE 42. RESISTIVE PULLUP TO INCREASE V_{OH}

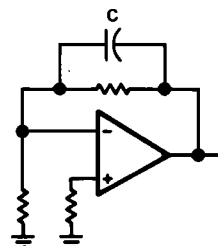


FIGURE 43. COMPENSATION FOR INPUT CAPACITANCE

electrostatic discharge protection

The TLC27L4 and TLC27L9 incorporate an internal electrostatic discharge (ESD) protection circuit that prevents functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2. Care should be exercised, however, when handling these devices, as exposure to ESD may result in the degradation of the device parametric performance. The protection circuit also causes the input bias currents to be temperature dependent and have the characteristics of a reverse-biased diode.

latch-up

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC27L4 and TLC27L9 inputs and outputs were designed to withstand – 100-mA surge currents without sustaining latch-up; however, techniques should be used to reduce the chance of latch-up whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltage should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the positive supply rail and ground and can be triggered by surges on the supply lines and/or voltages on either the output or inputs that exceed the supply voltage. Once latch-up occurs, the current flow is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor and usually results in the destruction of the device. The chance of latch-up occurring increases with increasing temperature and supply voltages.

TYPICAL APPLICATION DATA

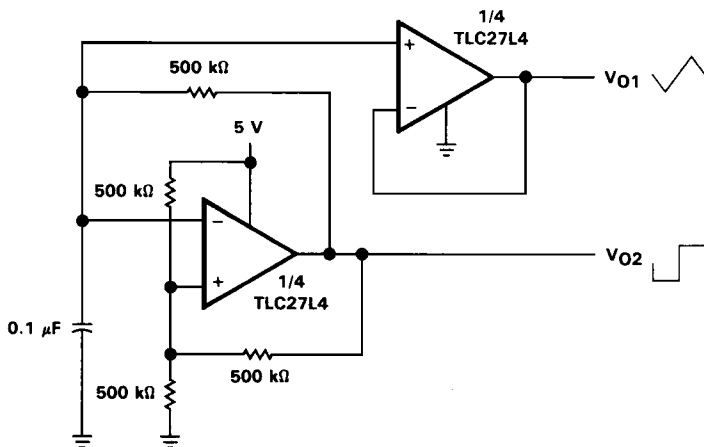
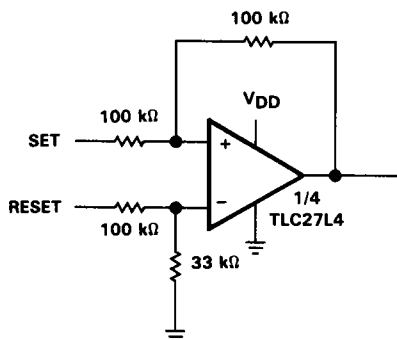


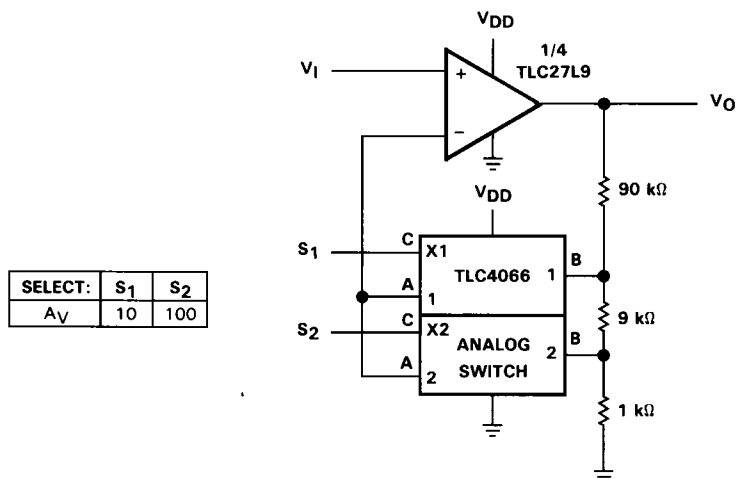
FIGURE 44. MULTIVIBRATOR



NOTE: $V_{DD} = 5 \text{ V to } 16 \text{ V}$

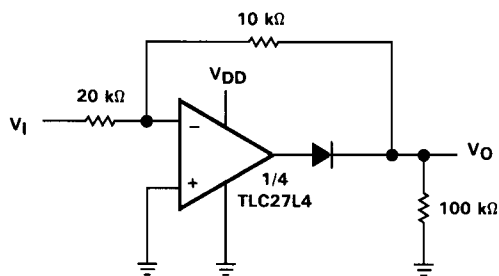
FIGURE 45. SET/RESET FLIP-FLOP

TYPICAL APPLICATION DATA



NOTE: $V_{DD} = 5\text{ V to }12\text{ V}$

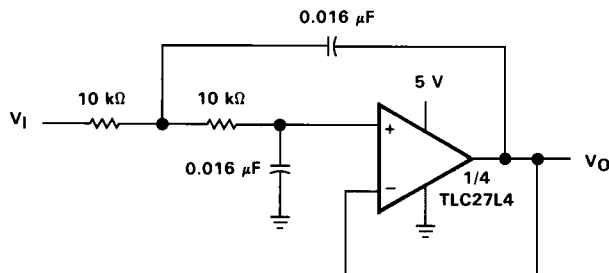
FIGURE 46. AMPLIFIER WITH DIGITAL GAIN SELECTION



NOTE: $V_{DD} = 5\text{ V to }16\text{ V}$

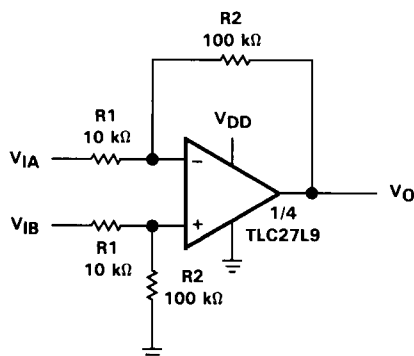
FIGURE 47. FULL-WAVE RECTIFIER

TYPICAL APPLICATION DATA



NOTE: Normalized to $F_C = 1 \text{ kHz}$ and $R_L = 10 \text{ k}\Omega$

FIGURE 48. TWO-POLE LOW-PASS BUTTERWORTH FILTER



NOTES: $V_{DD} = 5 \text{ V to } 16 \text{ V}$

$$V_O = \frac{R_2}{R_1} (V_{IB} - V_{IA})$$

FIGURE 49. DIFFERENCE AMPLIFIER

